


<b>Search Notes</b>  	<b>Application/Control No.</b>  10768368	<b>Applicant(s)/Patent Under Reexamination</b>  BUELOW ET AL.
	<b>Examiner</b>  Choi, Jacob Y	<b>Art Unit</b>  2875

SEARCHED			
Class	Subclass	Date	Examiner
362	294, 101, 373, 367	6/25/2005	JC

SEARCH NOTES		
Search Notes	Date	Examiner
Class/Subclass & Text Search Conducted by Examiner	6/25/2005	JC
Updated Search Conducted by Examiner	1/9/2006	JC
Updated Search Conducted by Examiner	5/31/2006	JC
Updated Search Conducted by Examiner	11/29/2006	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
362	294, 101, 373, 367	11/29/2006	JC